FINAL

Am27C020

2 Megabit (262,144 x 8-Bit) CMOS EPROM

Advanced Micro Devices

DISTINCTIVE CHARACTERISTICS

- **Fast access time**
  - — 70 ns
- **Low power consumption**
  - — 100 µA maximum CMOS standby current
- **JEDEC-approved pinout**
  - — Plug in upgrade of 1 Mbit EPROM
  - — Easy upgrade from 28-pin JEDEC EPROMs
- **Single +5 V power supply**
- **±10% power supply tolerance standard on most speeds**
- **100% Flashrite™ programming**
  - — Typical programming time of 32 seconds
- **Latch-up protected to 100 mA from –1 V to Vcc + 1 V**
- **High noise immunity**
- **Compact 32-pin DIP package requires no hardware change for upgrades to 8 Mbit**
- **DESC SMD No. 5962-90912**

GENERAL DESCRIPTION

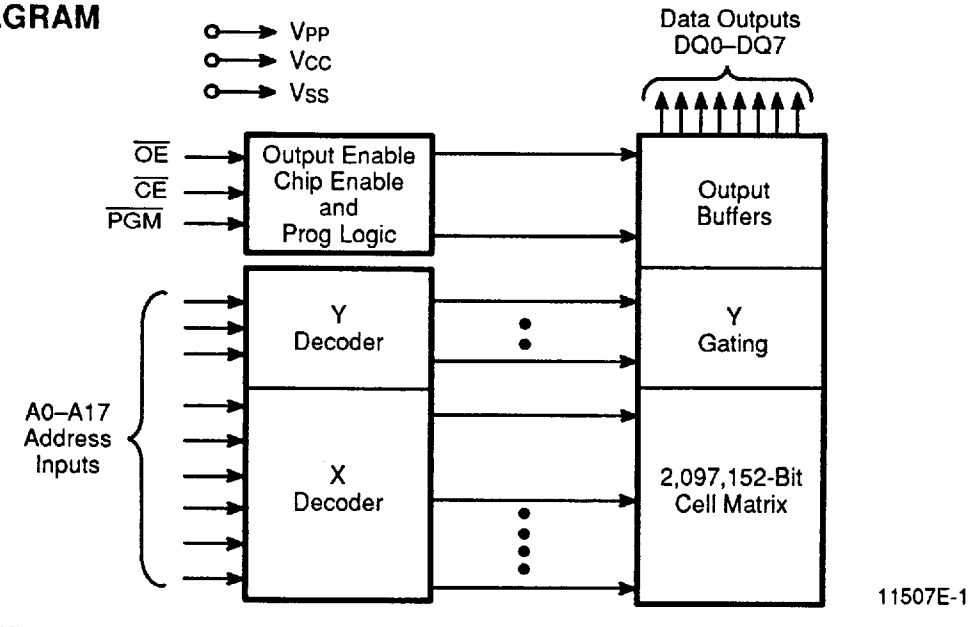
The Am27C020 is a 2 Mbit, ultraviolet erasable programmable read-only memory. It is organized as 256K words by 8 bits per word, operates from a single +5 V supply, has a static standby mode, and features fast single address location programming. Products are available in windowed ceramic DIP and LCC packages, as well as plastic one-time programmable (OTP) including TSOP, PLCC, and PDIP.

Typically, any byte can be accessed in less than 70 ns, allowing operation with high-performance microprocessors without any WAIT states. The Am27C020 offers separate Output Enable ($\overline{OE}$) and Chip Enable ($\overline{CE}$) controls, thus eliminating bus contention in a multiple bus microprocessor system.

AMD's CMOS process technology provides high speed, low power, and high noise immunity. Typical power consumption is only 100 mW in active mode, and 100 µW in standby mode.

All signals are TTL levels, including programming signals. Bit locations may be programmed singly, in blocks, or at random. The Am27C020 supports AMD's Flashrite programming algorithm (100 µs pulses) resulting in typical programming times of 32 seconds.

BLOCK DIAGRAM



11507E-1

Publication# 11507 Rev. E Amendment/0
Issue Date: June 1994

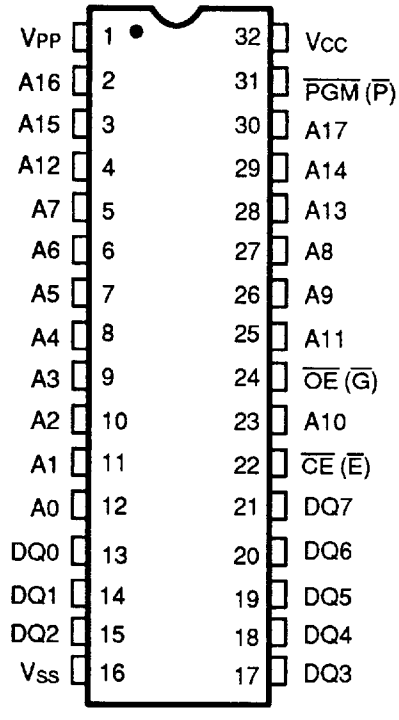
PRODUCT SELECTOR GUIDE

Family Part No.	Am27C020					
Ordering Part No: Vcc ±5%	-75					-255
Vcc ±10%	-70	-90	-120	-150	-200	-250
Max Access Time (ns)	70	90	120	150	200	250
$\overline{CE}$ ($\overline{E}$) Access (ns)	70	90	120	150	200	250
$\overline{OE}$ ($\overline{G}$) Access (ns)	40	40	50	65	75	100

CONNECTION DIAGRAMS

Top View

DIP



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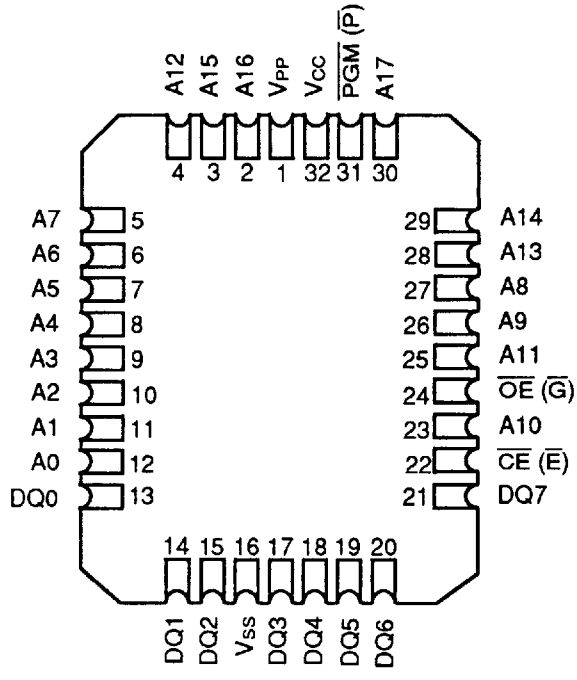
PLCC/LCC



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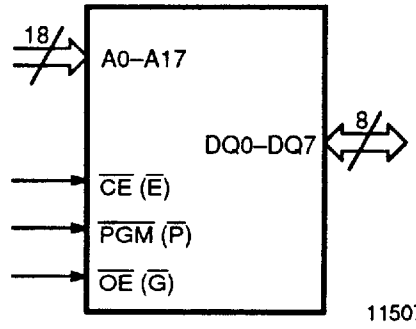
Notes:

1. *JEDEC nomenclature is in parentheses.*
2. *The 32-pin DIP to 32-pin LCC configuration varies from the JEDEC 28-pin DIP to 32-pin LCC configuration.*

PIN DESIGNATIONS

A0–A17	=	Address Inputs
$\overline{CE}$ ($\overline{E}$)	=	Chip Enable Input
DQ0–DQ7	=	Data Input/Outputs
$\overline{OE}$ ($\overline{G}$)	=	Output Enable Input
$\overline{PGM}$ ($\overline{P}$)	=	Program Enable Input
VCC	=	VCC Supply Voltage
VPP	=	Program Input Voltage
VSS	=	Ground

LOGIC SYMBOL



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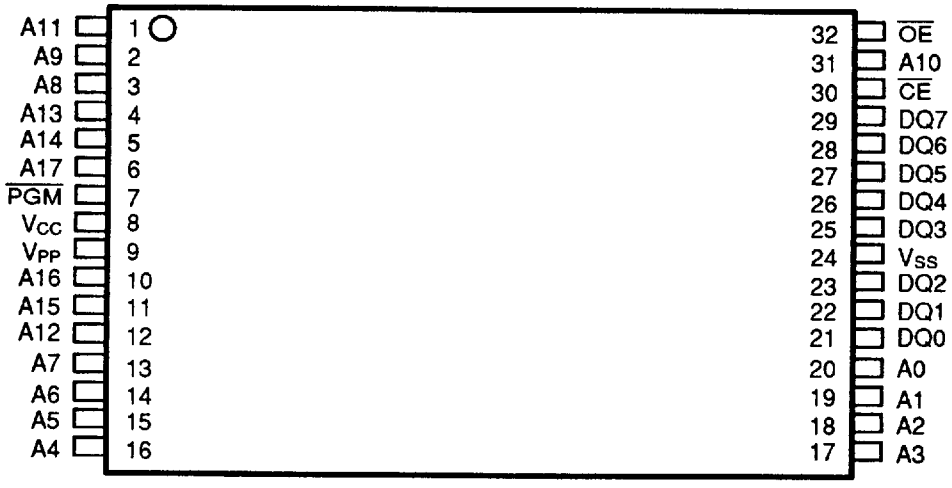
TSOP PACKAGE



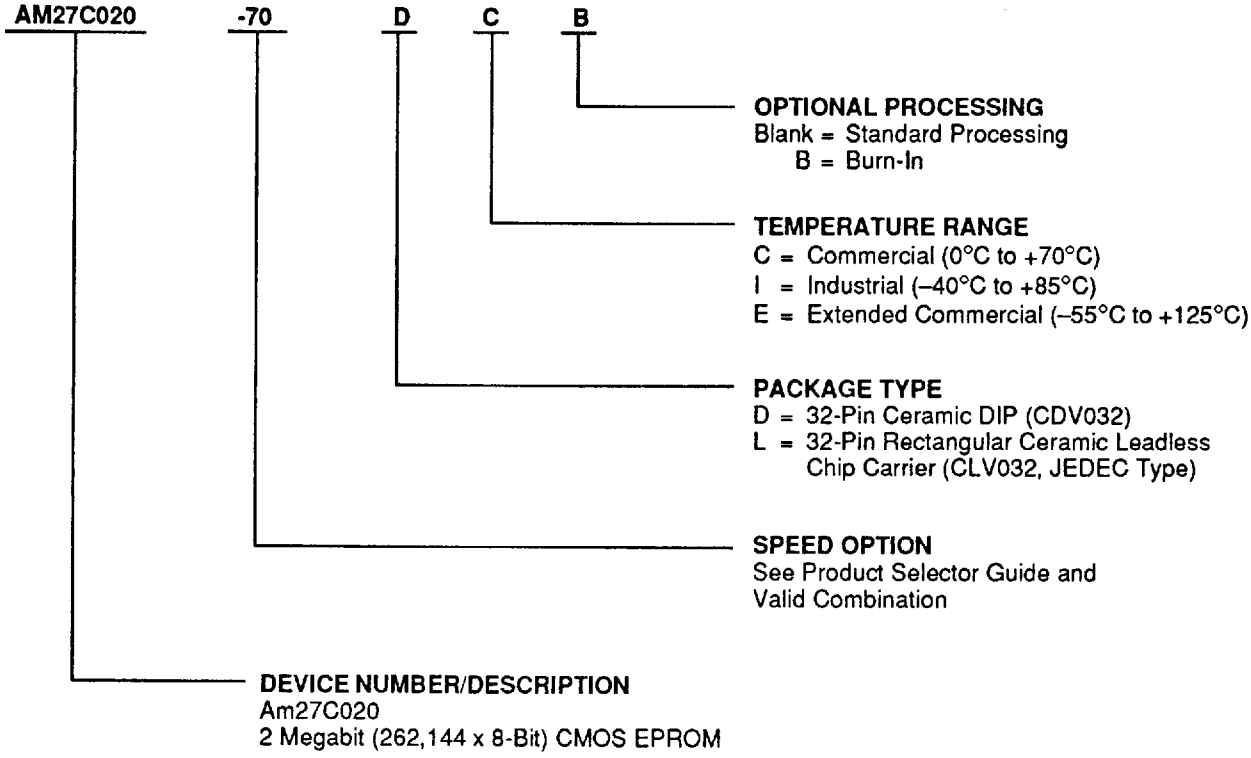
27C020 Standard Pinout 11507E-5

27C020 EPROM in 32 Lead TSOP

ORDERING INFORMATION

EPROM Products

AMD standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of:



Valid Combinations	
AM27C020-70	DC, DCB, DI, DIB, LC, LCB, LI, LIB
AM27C020-75	
AM27C020-90	
AM27C020-120	DC, DCB, DI, DIB, DE, DEB, LCB, LIB, LE, LEB, LC, LI
AM27C020-150	
AM27C020-200	
AM27C020-255	

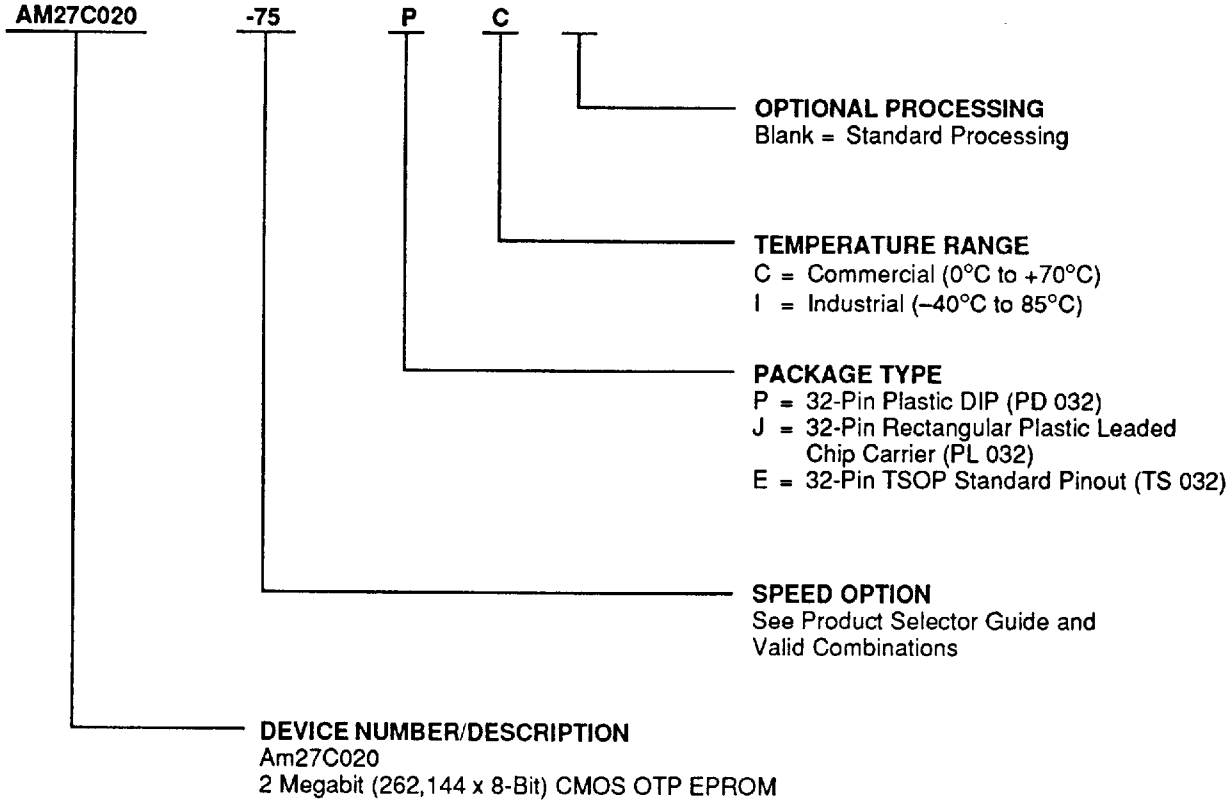
Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations and to check on newly released combinations.

ORDERING INFORMATION

OTP Products

AMD standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of:



Valid Combinations	
AM27C020-75	PC, JC, PI, JI, EC, EI
AM27C020-90	
AM27C020-120	
AM27C020-150	
AM27C020-200	
AM27C020-255	

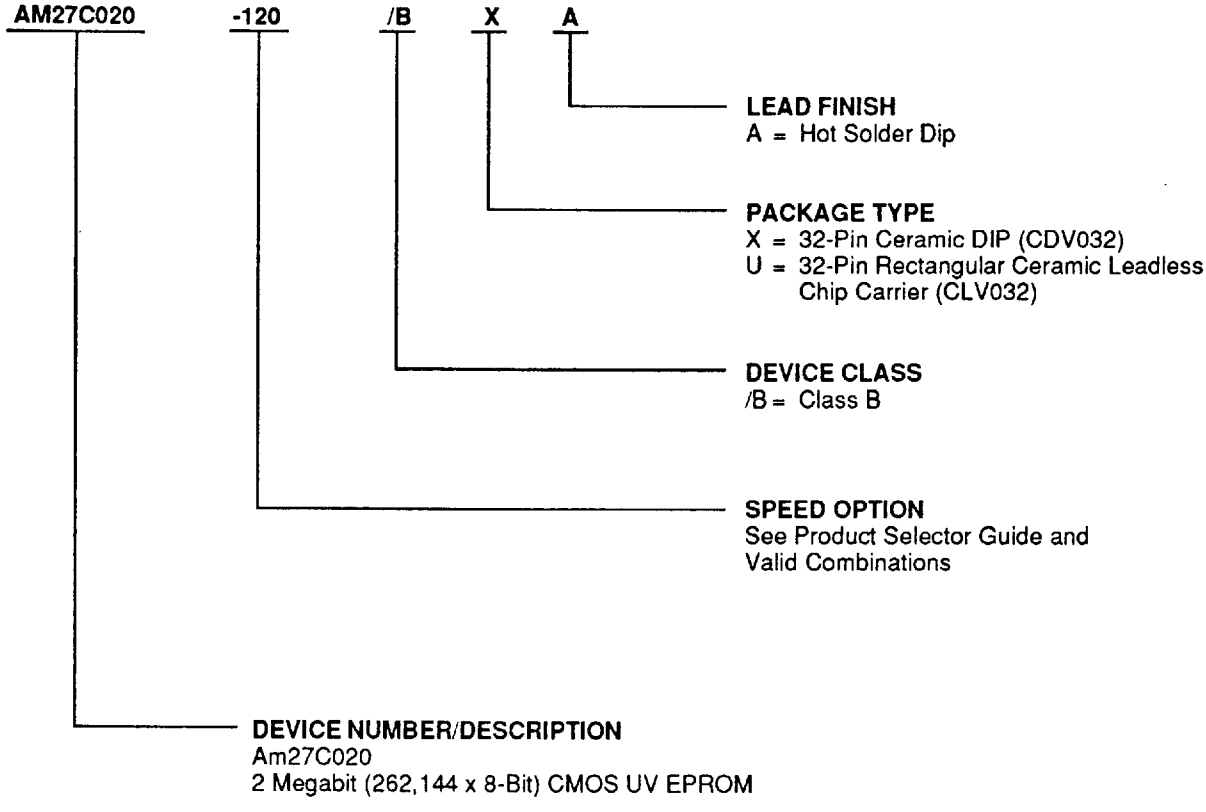
Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations and to check on newly released combinations.

MILITARY ORDERING INFORMATION

APL Products

AMD products for Aerospace and Defense applications are available in several packages and operating ranges. APL (Approved Products List) products are fully compliant with MIL-STD-883 requirements. The order number (Valid Combination) is formed by a combination of:



Valid Combinations	
AM27C020-120	/BXA, /BUA
AM27C020-150	
AM27C020-200	
AM27C020-250	

Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations and to check on newly released combinations.

Group A Tests

Group A tests consist of Subgroups 1, 2, 3, 7, 8, 9, 10, 11.

FUNCTIONAL DESCRIPTION

Erasing the Am27C020

In order to clear all locations of their programmed contents, it is necessary to expose the Am27C020 to an ultraviolet light source. A dosage of 15 W seconds/cm^2 is required to completely erase an Am27C020. This dosage can be obtained by exposure to an ultraviolet lamp —wavelength of 2537 Å— with intensity of 12,000 µW/cm^2 for 15 to 20 minutes. The Am27C020 should be directly under and about one inch from the source and all filters should be removed from the UV light source prior to erasure.

It is important to note that the Am27C020, and similar devices, will erase with light sources having wavelengths shorter than 4000 Å. Although erasure times will be much longer than with UV sources at 2537Å, nevertheless the exposure to fluorescent light and sunlight will eventually erase the Am27C020 and exposure to them should be prevented to realize maximum system reliability. If used in such an environment, the package window should be covered by an opaque label or substance.

Programming the Am27C020

Upon delivery, or after each erasure, the Am27C020 has all 2,097,152 bits in the "ONE", or HIGH state. "ZEROs" are loaded into the Am27C020 through the procedure of programming.

The programming mode is entered when 12.75 V ± 0.25 V is applied to the V_{PP} pin, $\overline{CE}$ and $\overline{PGM}$ are at V_{IL} and $\overline{OE}$ is at V_{IH}.

For programming, the data to be programmed is applied 8 bits in parallel to the data output pins.

The Flashrite algorithm reduces programming time by using 100 µs programming pulse and by giving each address only as many pulses as are necessary in order to reliably program the data. After each pulse is applied to a given address, the data in that address is verified. If the data does not verify, additional pulses are given until it verifies or the maximum is reached. This process is repeated while sequencing through each address of the Am27C020. This part of the algorithm is done at V_{CC} = 6.25 V to assure that each EPROM bit is programmed to a sufficiently high threshold voltage. After the final address is completed, the entire EPROM memory is verified at $V_{CC} = V_{PP}$ = 5.25 V.

Program Inhibit

Programming of multiple Am27C020s in parallel with different data is also easily accomplished. Except for $\overline{CE}$, all like inputs of the parallel Am27C020 may be common. A TTL low-level program pulse applied to an Am27C020 $\overline{CE}$ input with V_{PP} = 12.75 V ± 0.25 V, $\overline{PGM}$ LOW, and $\overline{OE}$ HIGH will program that Am27C020.

A high-level $\overline{CE}$ input inhibits the other Am27C020s from being programmed.

Program Verify

A verify should be performed on the programmed bits to determine that they were correctly programmed. The verify should be performed with $\overline{OE}$ and $\overline{CE}$ at V_{IL}, $\overline{PGM}$ at V_{IH}, and V_{PP} between 12.5 V and 13.0 V.

Auto Select Mode

The auto select mode allows the reading out of a binary code from an EPROM that will identify its manufacturer and type. This mode is intended for use by programming equipment for the purpose of automatically matching the device to be programmed with its corresponding programming algorithm. This mode is functional in the 25°C ± 5°C ambient temperature range that is required when programming the Am27C020.

To activate this mode, the programming equipment must force 12.0 V ± 0.5 V on address line A9 of the Am27C020. Two identifier bytes may then be sequenced from the device outputs by toggling address line A0 from V_{IL} to V_{IH}. All other address lines must be held at V_{IL} during auto select mode.

Byte 0 (A0 = V_{IL}) represents the manufacturer code, and Byte 1 (A0 = V_{IH}), the device identifier code. For the Am27C020, these two identifier bytes are given in the Mode Select table. All identifiers for manufacturer and device codes will possess odd parity, with the MSB (DQ7) defined as the parity bit.

Read Mode

The Am27C020 has two control functions, both of which must be logically satisfied in order to obtain data at the outputs. Chip Enable ($\overline{CE}$) is the power control and should be used for device selection. Output Enable ($\overline{OE}$) is the output control and should be used to gate data to the output pins, independent of device selection. Assuming that addresses are stable, address access time (t_{ACC}) is equal to the delay from $\overline{CE}$ to output (t_{CE}). Data is available at the outputs t_{OE} after the falling edge of $\overline{OE}$, assuming that $\overline{CE}$ has been LOW and addresses have been stable for at least $t_{ACC} - t_{OE}$.

Standby Mode

The Am27C020 has a CMOS standby mode which reduces the maximum VCC current to 100 µA. It is placed in CMOS-standby when $\overline{CE}$ is at V_{CC} ± 0.3 V. The Am27C020 also has a TTL-standby mode which reduces the maximum V_{CC} current to 1.0 mA. It is placed in TTL-standby when $\overline{CE}$ is at V_{IH}. When in standby mode, the outputs are in a high-impedance state, independent of the $\overline{OE}$ input.

Output OR-Tieing

To accommodate multiple memory connections, a two-line control function is provided to allow for:

- Low memory power dissipation, and
- Assurance that output bus contention will not occur

It is recommended that $\overline{CE}$ be decoded and used as the primary device-selecting function, while $\overline{OE}$ be made a common connection to all devices in the array and connected to the READ line from the system control bus. This assures that all deselected memory devices are in their low-power standby mode and that the outut pins are only active when data is desired from a particular memory device.

System Applications

During the switch between active and standby conditions, transient current peaks are produced on the rising and falling edges of Chip Enable. The magnitude of these transient current peaks is dependent on the output capacitance loading of the device. At a minimum, a 0.1 µF ceramic capacitor (high frequency, low inherent inductance) should be used on each device between V_{CC} and V_{SS} to minimize transient effects. In addition, to overcome the voltage drop caused by the inductive effects of the printed circuit board traces on EPROM arrays, a 4.7 µF bulk electrolytic capacitor should be used between V_{CC} and V_{SS} for each eight devices. The location of the capacitor should be close to where the power supply is connected to the array.

MODE SELECT TABLE

Mode \ Pins		$\overline{CE}$	$\overline{OE}$	$\overline{PGM}$	A0	A9	V_{PP}	Outputs
Read		V_{IL}	V_{IL}	X	X	X	X	D_{OUT}
Output Disable		V_{IL}	V_{IH}	X	X	X	X	High Z
Standby (TTL)		V_{IH}	X	X	X	X	X	High Z
Standby (CMOS)		$V_{CC} \pm 0.3$ V	X	X	X	X	X	High Z
Program		V_{IL}	V_{IH}	V_{IL}	X	X	V_{PP}	D_{IN}
Program Verify		V_{IL}	V_{IL}	V_{IH}	X	X	V_{PP}	D_{OUT}
Program Inhibit		V_{IH}	X	X	X	X	V_{PP}	High Z
Auto Select (Note 3)	Manufacturer Code	V_{IL}	V_{IL}	X	V_{IL}	V_H	X	01H
	Device Code	V_{IL}	V_{IL}	X	V_{IH}	V_H	X	97H

Notes:

1. *$V_H = 12.0\ V \pm 0.5\ V$*
2. *X can be either V_{IL} or V_{IH}*
3. *A1–A8 = A10–A17 = V_{IL}*

ABSOLUTE MAXIMUM RATINGS

Storage Temperature:
OTP Products ..... −65°C to +125°C
All Other Products ..... −65°C to +150°C

Ambient Temperature
with Power Applied ..... −55°C to +125°C

Voltage with Respect to V_{SS}:
All pins except A9, V_{PP}, and
V_{CC} (Note 1) ..... −0.6 V to V_{CC} + 0.6 V

A9 and V_{PP} (Note 2) ..... −0.6 V to 13.5 V

V_{CC} ..... −0.6 V to 7.0 V

Notes:

1. *During transitions, the input may overshoot V_{SS} to −2.0 V for periods of up to 20 ns. Maximum DC voltage on input and I/O may overshoot to V_{CC} + 2.0 V for periods of up to 20 ns.*
2. *During transitions, A9 and V_{PP} may overshoot V_{SS} to −2.0 V for periods of up to 20 ns. A9 and V_{PP} must not exceed 13.5 V for any period of time.*

Stresses above those listed under Absolute Maximum Ratings may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to absolute maximum ratings for extended periods may affect device reliability.

OPERATING RANGES

Commercial (C) Devices

Case Temperature (T_C) ..... 0°C to +70°C

Industrial (I) Devices

Case Temperature (T_C) ..... −40°C to +85°C

Extended Commercial (E) Devices

Case Temperature (T_C) ..... −55°C to +125°C

Military (M) Devices

Case Temperature (T_C) ..... −55°C to +125°C

Supply Read Voltages:

V_{CC} for Am27C020-XX5 ..... +4.75 V to +5.25 V
V_{CC} for Am27C020-XX0 ..... +4.50 V to +5.50 V

Operating ranges define those limits between which the functionality of the device is guaranteed.

DC CHARACTERISTICS over operating ranges unless otherwise specified (Notes 1, 2, and 4) (for APL products, Group A, Subgroups 1, 2, 3, 6, and 7 are tested unless otherwise noted)

PRELIMINARY						
Parameter Symbol	**Parameter Description**	**Test Conditions**		**Min**	**Max**	**Unit**
V_{OH}	Output HIGH Voltage	I_{OH} = −400 µA		2.4		V
V_{OL}	Output LOW Voltage	I_{OL} = 2.1 mA			0.45	V
V_{IH}	Input HIGH Voltage			2.0	V_{CC} + 0.5	V
V_{IL}	Input LOW Voltage			−0.5	+0.8	V
I_{LI}	Input Load Current	V_{IN} = 0 V to V_{CC}			1.0	µA
I_{LO}	Output Leakage Current	V_{OUT} = 0 V to V_{CC}			5.0	µA
I_{CC1}	V_{CC} Active Current (Note 3)	$\overline{CE}$ = V_{IL}, f = 10 MHz, I_{OUT} = 0 mA	C/I Devices		30	mA
			E/M Devices		60	
I_{CC2}	V_{CC} TTL Standby Current	$\overline{CE}$ = V_{IH}, $\overline{OE}$ = V_{IL}			1.0	mA
I_{CC3}	V_{CC} CMOS Standby Current	$\overline{CE}$ = V_{CC} + 0.3 V			100	µA
I_{PP1}	V_{PP} Supply Current (Read)	$\overline{CE}$ = $\overline{OE}$ = V_{IL}, V_{PP} = V_{CC}			100	µA

Notes:

1. *V_{CC} must be applied simultaneously or before V_{PP}, and removed simultaneously or after V_{PP}.*
2. ***Caution:** The Am27C020 must not be removed from (or inserted into) a socket when V_{CC} or V_{PP} is applied.*
3. *I_{CC1} is tested with $\overline{OE}$ = V_{IH} to simulate open outputs.*
4. *Minimum DC Input Voltage is −0.5 V. During transitions, the inputs may overshoot to −2.0 V for periods less than 20 ns. Maximum DC Voltage on output pins is V_{CC} + 0.5 V, which may overshoot to V_{CC} + 2.0 V for periods less than 20 ns.*

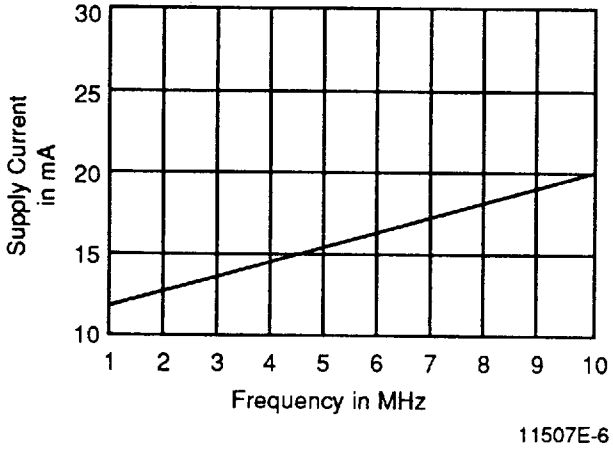


Figure 1. Typical Supply Current vs. Frequency
V_{CC} = 5.5 V, T = 25°C

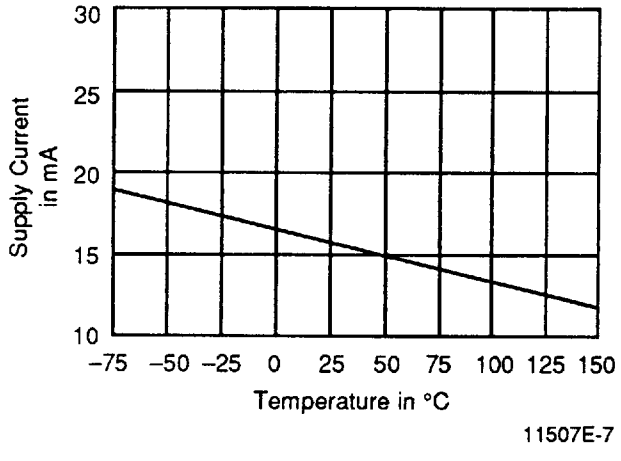


Figure 2. Typical Supply Current vs. Temperature
V_{CC} = 5.5 V, f = 5 MHz

CAPACITANCE

Parameter Symbol	Parameter Description	Test Conditions	CDV032		CLV032		PD 032		PL 032		TS 032		Unit
			Typ	Max	Typ	Max	Typ	Max	Typ	Max	Typ	Max	
C_{IN}	Input Capacitance	V_{IN} = 0 V	10	12	8	10	10	12	8	10	10	12	pF
C_{OUT}	Output Capacitance	V_{OUT} = 0 V	12	15	9	12	12	15	9	12	12	14	pF

Note:

1. *This parameter is only sampled and not 100% tested.*

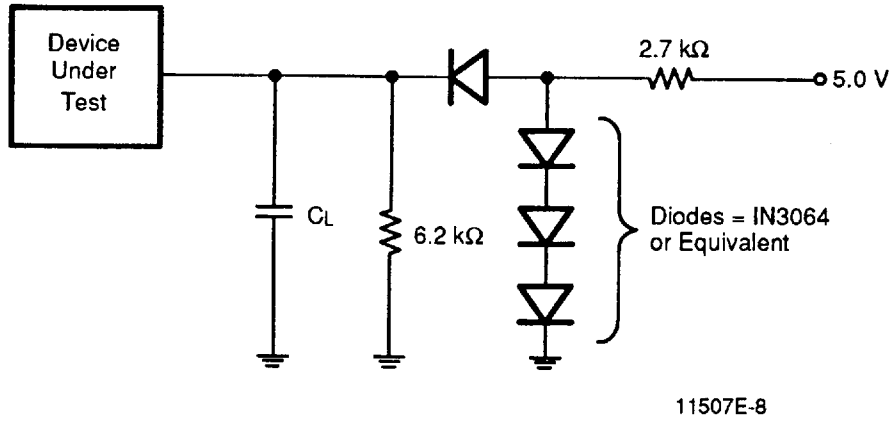
SWITCHING CHARACTERISTICS over operating ranges unless otherwise specified (Notes 1, 3, and 4) (for APL products, Group A, Subgroups 9, 10, and 11 are tested unless otherwise noted)

Parameter Symbols		Parameter Description	Test Conditions		Am27C020						Unit
JEDEC	Standard				-75 -70	-90	-120	-150	-200	-255 -250	
t_{AVQV}	t_{ACC}	Address to Output Delay	$\overline{CE}$ = $\overline{OE}$ = V_{IL}	Min							ns
				Max	70	90	120	150	200	250	
t_{ELQV}	t_{CE}	Chip Enable to Output Delay	$\overline{OE}$ = V_{IL}	Min							ns
				Max	70	90	120	150	200	250	
t_{GLQV}	t_{OE}	Output Enable to Output Delay	$\overline{CE}$ = V_{IL}	Min							ns
				Max	40	40	50	55	60	75	
t_{EHQZ}, t_{GHQZ}	t_{DF} (Note 2)	Chip Enable HIGH or Output Enable HIGH, whichever comes first, to Output Float		Min							ns
				Max	25	25	30	30	40	60	
t_{AXQX}	t_{OH}	Output Hold from Addresses, $\overline{CE}$, or $\overline{OE}$, whichever occurred first		Min	0	0	0	0	0	0	ns
				Max							

Notes:

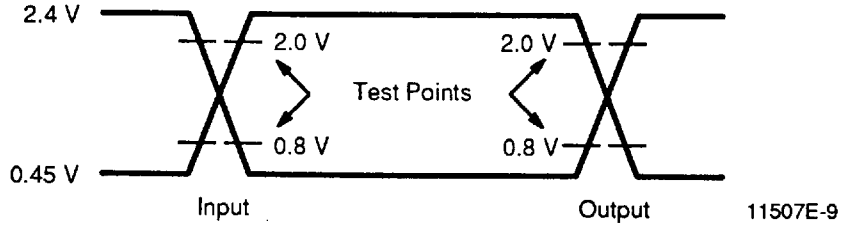
1. *V_{CC} must be applied simultaneously or before V_{PP}, and removed simultaneously or after V_{PP}.*
2. *This parameter is only sampled and not 100% tested.*
3. ***Caution:** The Am27C020 must not be removed from, or inserted into a socket or board when V_{PP} or V_{CC} is applied.*
4. *Output Load: 1 TTL gate and C_L = 100 pF,*
   Input Rise and Fall Times: 20 ns,
   Input Pulse Levels: 0.45 V to 2.4 V,
   Timing Measurement Reference Level—Inputs: 0.8 V and 2 V,
   Outputs: 0.8 V and 2 V

SWITCHING TEST CIRCUIT



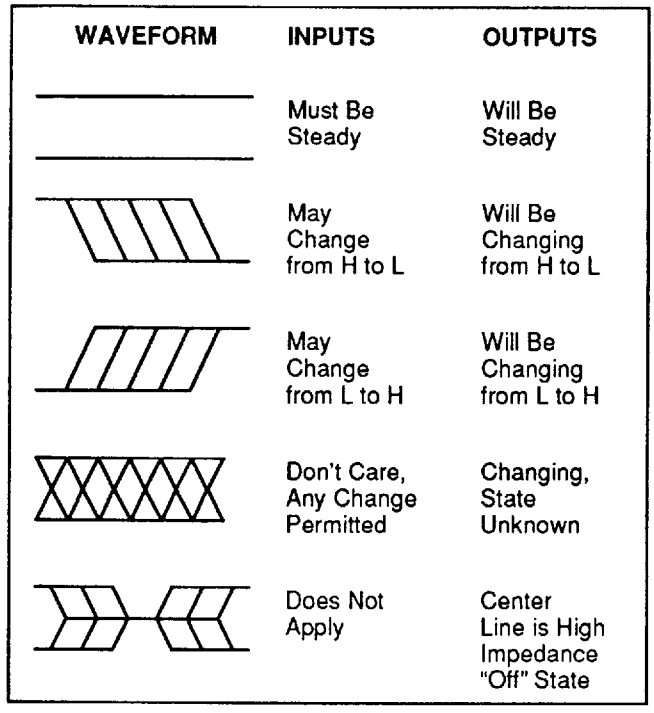
C_L = 100 pF including jig capacitance

SWITCHING TEST WAVEFORM



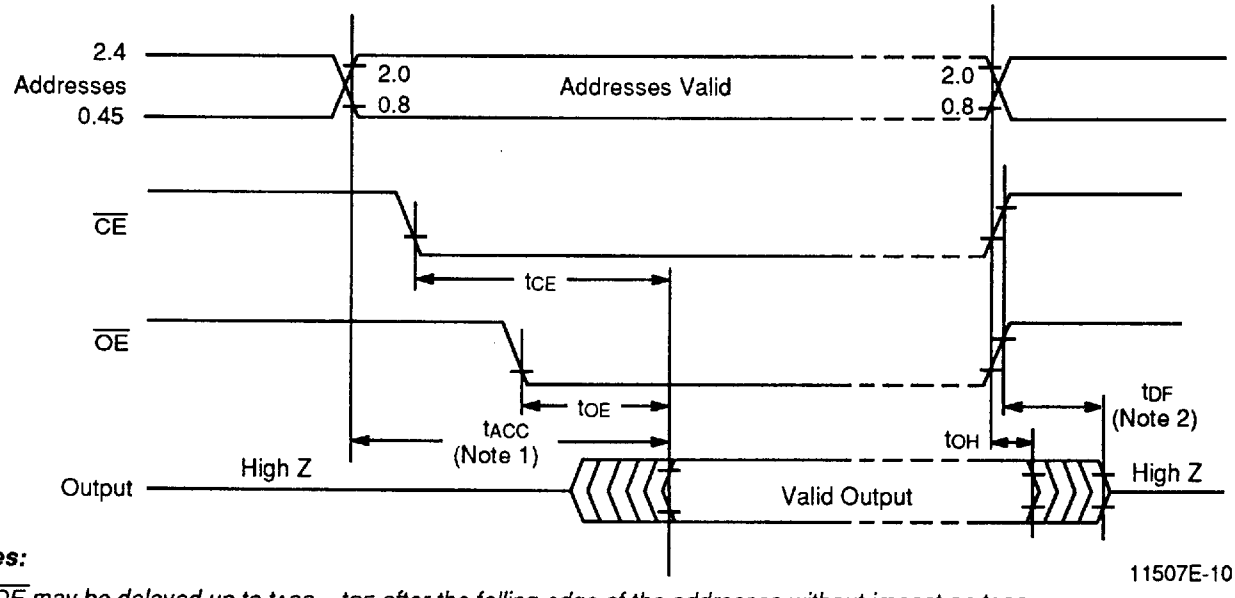
AC Testing: Inputs are driven at 2.4 V for a Logic "1" and 0.45 V for a Logic "0." Input pulse rise and fall times are ≤ 20 ns.

KEY TO SWITCHING WAVEFORMS



KS000010

SWITCHING WAVEFORM



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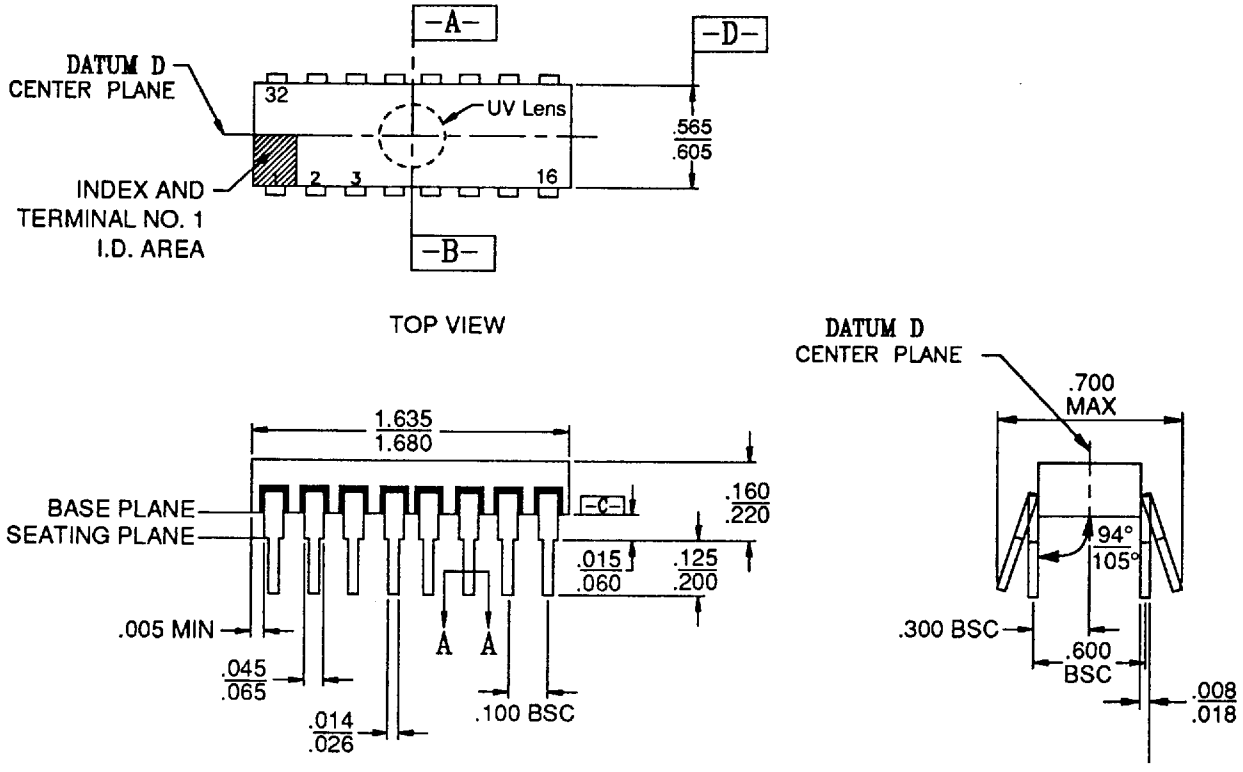
Notes:

1. *$\overline{OE}$ may be delayed up to $t_{ACC} - t_{OE}$ after the falling edge of the addresses without impact on t_{ACC}.*
2. *t_{DF} is specified from $\overline{OE}$ or $\overline{CE}$, whichever occurs first.*

PHYSICAL DIMENSIONS*

CDV032

32-Pin Ceramic DIP with UV Lens (measured in inches)

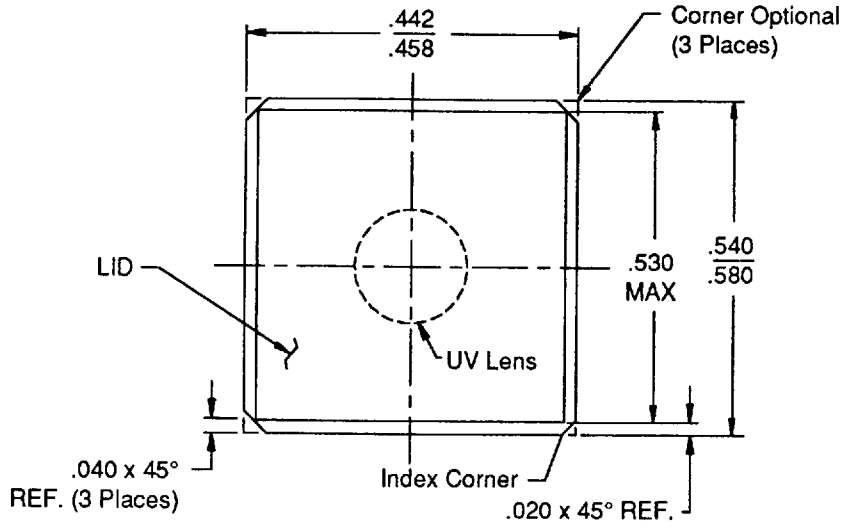


16-000038H-3
CDV032
DB11
6-17-94 ae

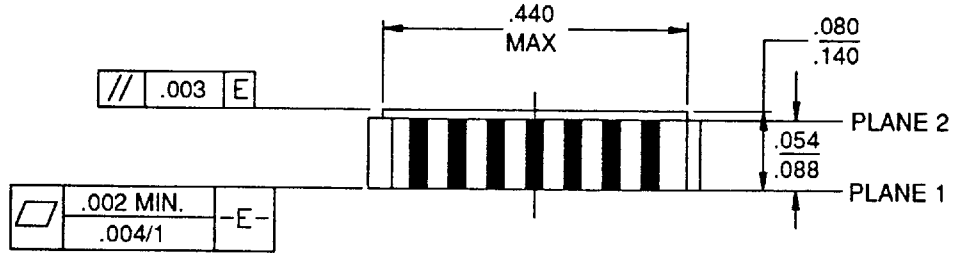
PHYSICAL DIMENSIONS*

CLV032

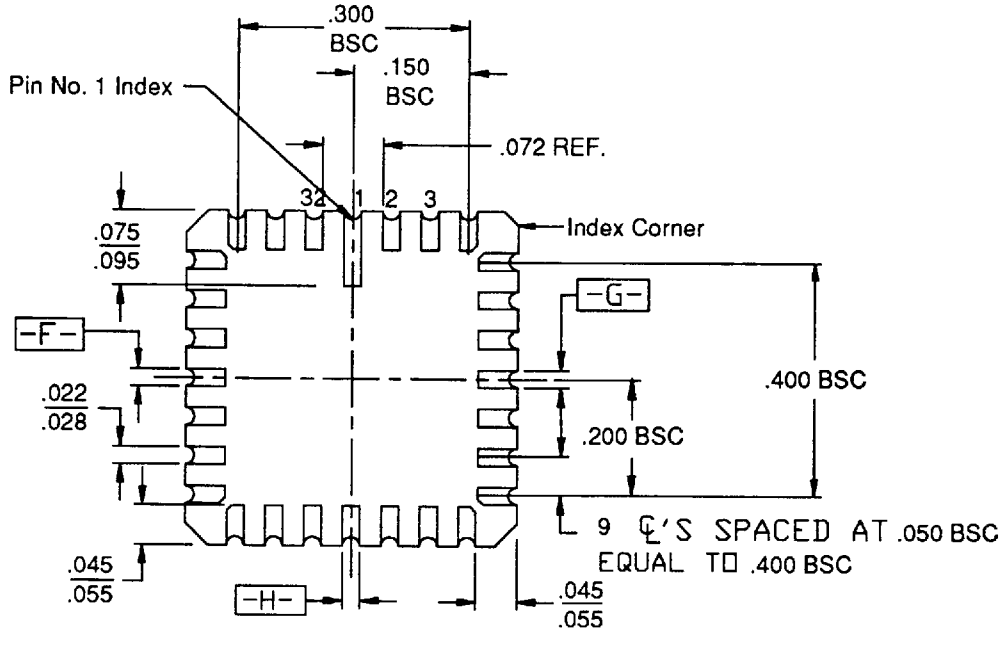
32-Pin Rectangular Ceramic Leadless Chip Carrier with UV Lens (measured in inches)



TOP VIEW



SIDE VIEW



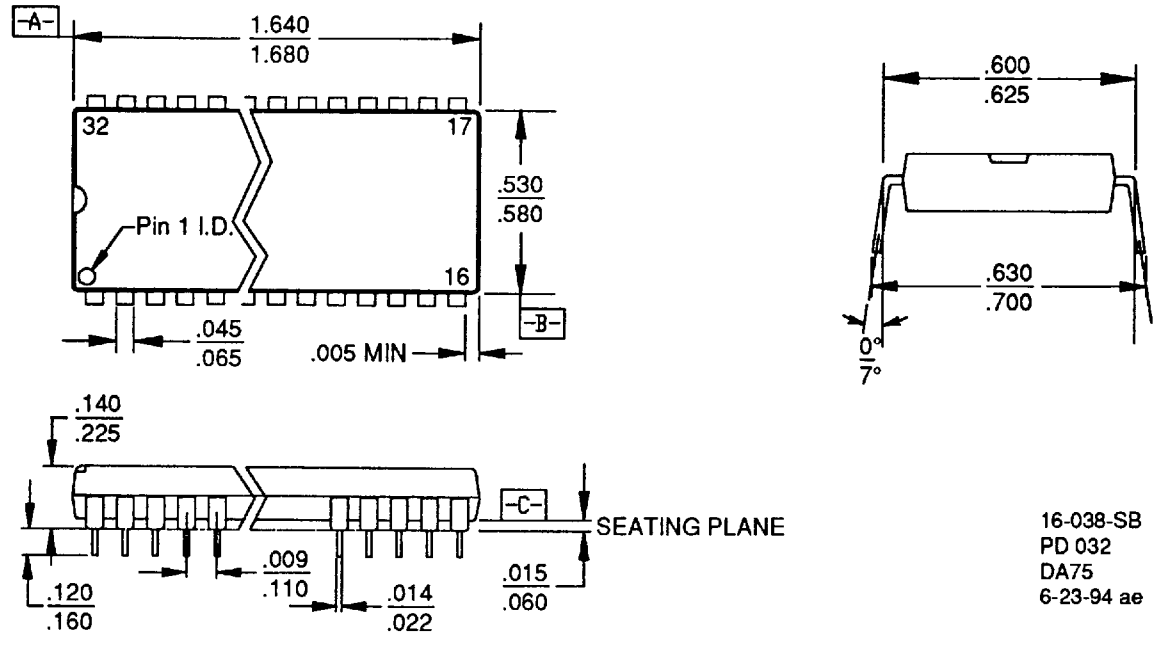
BOTTOM VIEW

.16-0000038C-5
CLV032
DA45
6-23-94 ae

PHYSICAL DIMENSIONS*

PD 032

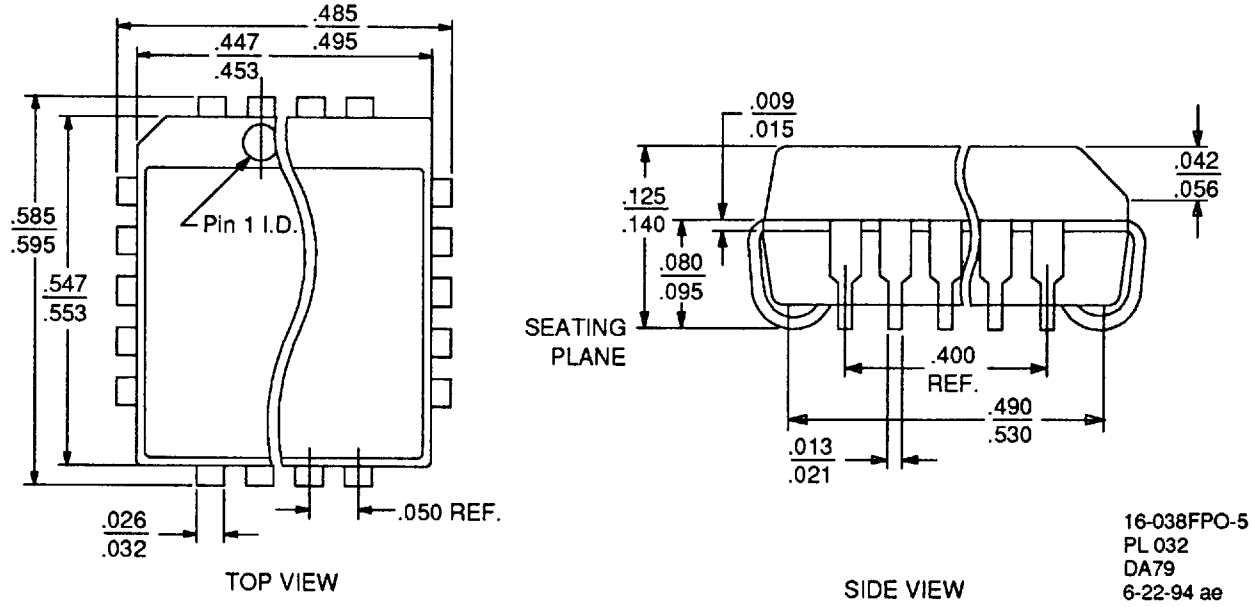
32-Pin Plastic Dual-In-Line Package (measured in inches)



16-038-SB
PD 032
DA75
6-23-94 ae

PL 032

32-Pin Plastic Leaded Chip Carrier (measured in inches)

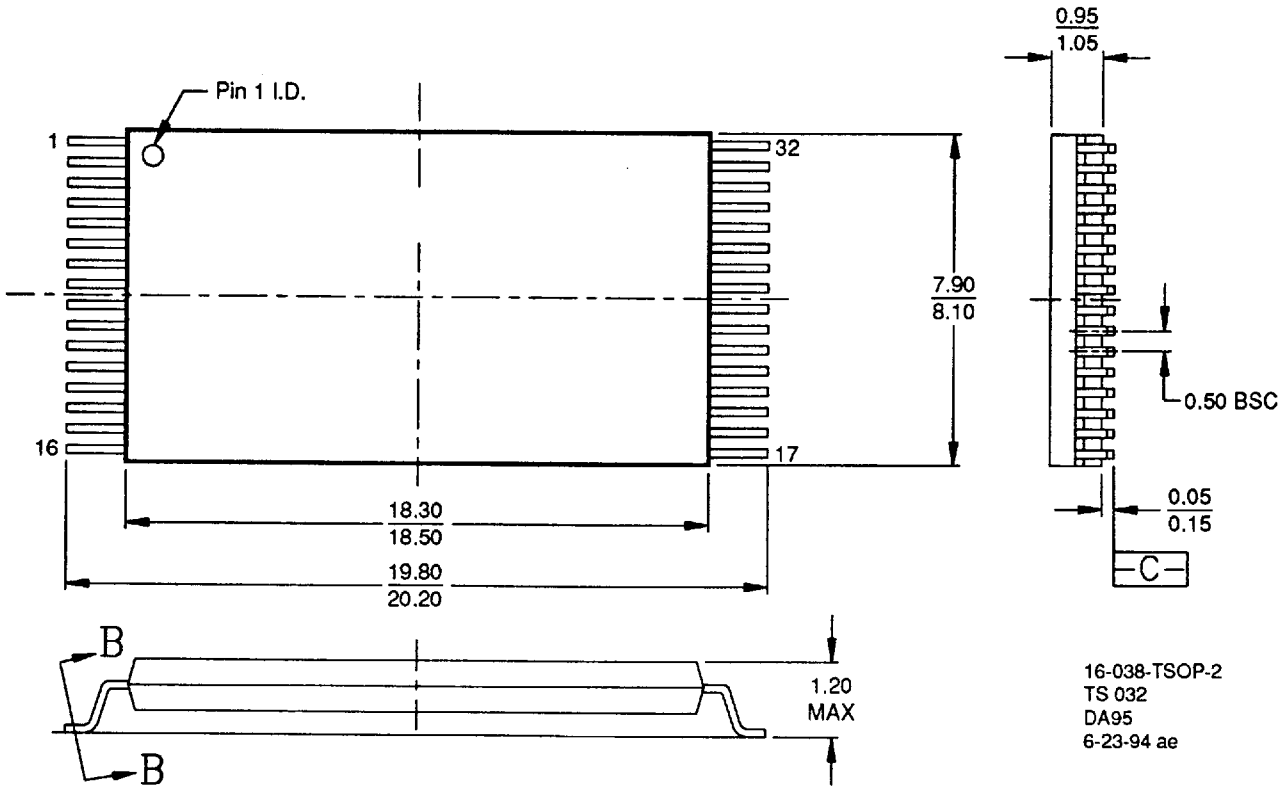


16-038FPO-5
PL 032
DA79
6-22-94 ae

PHYSICAL DIMENSIONS*

TS 032

32-Pin Thin Small Outline, Standard Pin-Out (measured in millimeters)



16-038-TSOP-2
TS 032
DA95
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